

<b>Notice of References Cited</b>	Application/Control No. 10/629,886	Applicant(s)/Patent Under Reexamination METZ ET AL.	
	Examiner Michael Y. Won	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,479,587	12-1995	Campbell et al.	358/1.17
*	B	US-5,768,424	06-1998	Long, Timothy	382/232
*	C	US-5,999,272	12-1999	Dow et al.	358/1.15
*	D	US-6,138,164	10-2000	Kobata et al.	709/231
*	E	US-6,348,969	02-2002	Ikeda, Jun	358/1.15
*	F	US-2002/0076245	06-2002	Aiyama, Kenji	400/61
*	G	US-6,453,071	09-2002	Ito et al.	382/232
*	H	US-6,469,986	10-2002	Lecheler et al.	370/252
*	I	US-2002/0154331	10-2002	Yamauchi et al.	358/1.15
*	J	US-6,625,671	09-2003	Collette et al.	710/52
*	K	US-6,842,768	01-2005	Shaffer et al.	709/203
*	L	US-2005/0069363	03-2005	Aoki et al.	400/076
*	M	US-7,024,045	04-2006	McIntyre, Kristen A.	382/239

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.